Search Notes		
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Application N .	Applicant(s)
10/002,724	MADRID ET AL.
Examiner	Art Unit
Julio J. Maldonado	2823

	SEARCHED		
Class	Subclass	Date	Examiner
438	113	5/25/2004	Sen
	•		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		-	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East (USPAT; USPGPUB) blade with (plurality or multiple) (semiconductor with apparatus with packaging) and cutting	5/25/2004	LOD.